

September 9, 2010



LP2985LV

Micropower 150 mA Low-Noise Low-Dropout Regulator in SOT-23 and micro SMD packages for Applications with Output Voltages ≤ 2.0V Designed for Use with Very Low ESR Output Capacitors

General Description

The LP2985LV is a 150 mA, fixed-output voltage regulator designed to provide high performance and low noise in applications requiring output voltages $\leq 2.0V$.

Using an optimized VIP[®] (Vertically Integrated PNP) process, the LP2985LV delivers unequalled performance in all specifications critical to battery-powered designs:

Ground Pin Current: Typically 825 $\mu A @ 150$ mA load, and 75 $\mu A @ 1$ mA load.

Enhanced Stability: The LP2985LV is stable with output capacitor ESR as low as 5 m Ω , which allows the use of ceramic capacitors on the output.

Sleep Mode: Less than 1 μ A quiescent current when ON/OFF pin is pulled low.

Smallest Possible Size: micro SMD package uses absolute minimum board space.

Precision Output: 1% tolerance output voltages available (A grade).

Low Noise: By adding a 10 nF bypass capacitor, output noise can be reduced to 30 μ V (typical).

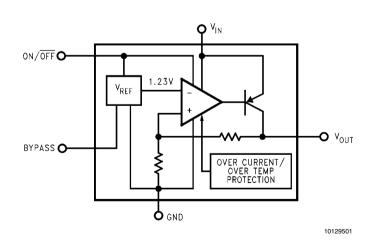
Features

- Guaranteed 150 mA output current
- Smallest possible size (micro SMD)
- Requires minimum external components
- Stable with low-ESR output capacitor
- <1 µA quiescent current when shut down</p>
- Low ground pin current at all loads
- Output voltage accuracy 1% (A Grade)
- High peak current capability
- Wide supply voltage range (16V max)
- Low Z_{OUT} : 0.3 Ω typical (10 Hz to 1 MHz)
- Overtemperature/overcurrent protection
- -40°C to +125°C junction temperature range
- Custom voltages available

Applications

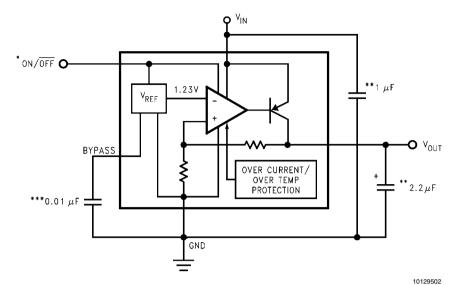
- Cellular Phone
- Palmtop/Laptop Computer
- Personal Digital Assistant (PDA)
- Camcorder, Personal Stereo, Camera

Block Diagram



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Basic Application Circuit



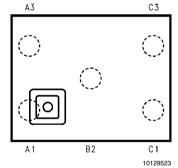
*ON/OFF input must be actively terminated. Tie to V_{IN} if this function is not to be used.

Minimum capacitance is shown to ensure stability (may be increased without limit). Ceramic capacitor required for output (see Application Hints). *Reduces output noise (may be omitted if application is not noise critical). Use ceramic or film type with very low leakage current (see Application Hints).

Connection Diagrams



micro SMD, 5 Bump Package



Note: The actual physical placement of the package marking will vary from part to part. Package marking contains date code and lot traceability information, and will vary considerably. Package marking does not correlate to device type. Top View

Pin Descriptions

Nama	Pin Number		Function		
Name	SOT-23	micro SMD	Function		
V _{IN}	1	C3	Input Voltage		
GND	2	A1	Common Ground (device substrate)		
ON/OFF	3	A3	Logic high enable input		
BYPASS	4	B2	Bypass capacitor for low noise operation		
V _{OUT}	5	C1	Regulated output voltage		

Ordering Information

Dutput Voltage (V) Grade		Order Information	Package Marking	Supplied as:
OT-23, 5-Lead Sma	all Outline Packa	ge (M5)		
	А	LP2985AIM5-1.5	LCHA	1000 Units on Tape and Reel
1.5		LP2985AIM5X-1.5	LCHA	3000 Units on Tape and Reel
1.5	STD	LP2985IM5-1.5	LCHB	1000 Units on Tape and Reel
		LP2985IM5X-1.5	LCHB	3000 Units on Tape and Reel
	А	LP2985AIM5-1.8	LAYA	1000 Units on Tape and Reel
1.0	A	LP2985AIM5X-1.8	LAYA	3000 Units on Tape and Reel
1.8	STD	LP2985IM5-1.8	LAYB	1000 Units on Tape and Reel
		LP2985IM5X-1.8	LAYB	3000 Units on Tape and Reel
	А	LP2985AIM5-2.0	LCDA	1000 Units on Tape and Reel
2.0		LP2985AIM5X-2.0	LCDA	3000 Units on Tape and Reel
2.0	STD	LP2985IM5-2.0	LCDB	1000 Units on Tape and Reel
		LP2985IM5X-2.0	LCDB	3000 Units on Tape and Reel
icro SMD, 5 Bump	Package (TPA0	5 - 170 µm ball)	-	
	А	LP2985AITP-1.5		250 Units on Tape and Reel
1.5	A	LP2985AITPX-1.5		3000 Units on Tape and Reel
1.5	STD	LP2985ITP-1.5		250 Units on Tape and Reel
		LP2985ITPX-1.5		3000 Units on Tape and Reel
		LP2985AITP-1.8		250 Units on Tape and Reel
1.8	A	LP2985AITPX-1.8		3000 Units on Tape and Reel
1.8	STD	LP2985ITP-1.8		250 Units on Tape and Reel
	510	LP2985ITPX-1.8		3000 Units on Tape and Reel

TABLE 1. Package Marking and Ordering Information

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Storage Temperature Range	–65°C to +150°C
Operating Junction Temperature	
Range	-40°C to +125°C
Lead Temp. (Soldering, 5 sec.)	260°C
ESD Rating (<i>Note 2</i>)	2 kV

Power Dissipation (Note 3) Internally Limited Input Supply Voltage (Survival) -0.3V to +16V Input Supply Voltage (Operating) 2.2V to +16V Shutdown Input Voltage (Survival) -0.3V to +16V Output Voltage (Survival, (Note 4)) -0.3V to +9V Short Circuit I_{OUT} (Survival) Input-Output Voltage (Survival, -0.3V to +16V

Protected

(Note 5))

Electrical Characteristics (Note 10)

Limits in standard typeface are for T₁ = 25°C. and limits in **boldface type** apply over the full operating temperature range. Unless otherwise specified: $V_{IN} = V_{O(NOM)} + 1V$, $I_L = 1$ mA, $C_{IN} = 1$ µF, $C_{OUT} = 4.7$ µF, $V_{ON/OFF} = 2V$.

Symbol	Parameter	Conditions	Тур	LP2985AI-X.X (<i>Note 6</i>)		LP2985I-X.X (<i>Note 6</i>)		Units
				۵V _o	Output Voltage	I _L = 1 mA		-1.0
0	Tolerance	$1 \text{ mA} \leq I_1 \leq 50 \text{ mA}$		-1.5	1.5	-2.5	2.5	2.5 3.5 %V _{NOM}
		-		-2.5	2.5	-3.5	3.5	
		$1 \text{ mA} \leq \text{I}_{\text{L}} \leq 150 \text{ mA}$		-2.5	2.5	-3.0	3.0	
				-3.5	3.5	-4.0	4.0	
Δ۷ο	Output Voltage	$V_{O}(NOM)+1V \le V_{IN} \le 16V$	0.007		0.014		0.014	
ΔV_{IN}	Line Regulation				0.032		0.032	%/V
GND	Ground Pin Current	I _L = 0	65		95		95	
		-			125		125	
		I _L = 1 mA	75		110		110	
					170		170	
		I _L = 10 mA	120		220		220	
					400		400	
		I _L = 50 mA	300		500		500	μA
					900		900	
		I _L = 150 mA	825		1200		1200	
					2000		2000	
		V _{ON/OFF} < 0.3V	0.01		0.8		0.8	
		V _{ON/OFF} < 0.15V	0.05		2		2	
V _{IN} (min)	Minimum Input Voltage Required To maintain Output Regulation (<i>Note 9</i>)		2.05		2.20		2.20	V
		IL = 50mA	120		150		150	
V _{IN} - V _{OUT}	Dropout Voltage (<i>Note 9</i>)				250		250	mV
IN OUI		IL = 150mA	280		350		350	
				1.0	600	1.0	600	
V _{ON/OFF}	ON/OFF Input Voltage (<i>Note 7</i>)	High = O/P ON	1.4	1.6		1.6		v
		Low = O/P OFF	0.55		0.15		0.15	
I _{ON/OFF}	ON/OFF Input Current	$V_{ON/OFF} = 0$	0.01		-2		-2	μA
		$V_{ON/OFF} = 5V$	5		15		15	ļ .
e _n	Output Noise	BW = 300 Hz to 50 kHz,						
	Voltage (RMS)	$C_{OUT} = 10 \ \mu F$ $C_{BYPASS} = 10 \ nF$ $V_{OUT} = 1.8V$	30					μV

Symbol	Parameter	Conditions	Тур	LP2985AI-X.X (<i>Note 6</i>)		LP2985I-X.X (<i>Note 6</i>)		Units
				Min	Max	Min	Max	
$\frac{\Delta V_{OUT}}{\Delta V_{IN}}$	Ripple Rejection	f = 1 kHz, C_{BYPASS} = 10 nF C_{OUT} = 10 μ F	45					dB
I _O (SC)	Short Circuit Current	R _L = 0 (Steady State) (<i>Note 8</i>)	400					mA
I _O (PK)	Peak Output Current	$V_{OUT} \ge V_{o}(NOM) - 5\%$	350					mA

Note 1: "Absolute Maximum Ratings" indicate limits beyond which damage to the component may occur. Electrical specifications do not apply when operating the device outside of its rated operating conditions.

Note 2: The ESD rating of pins 3 and 4 for the SOT-23 package, or pins 5 and 2 for the micro SMD package, is 1 kV.

Note 3: The maximum allowable power dissipation is a function of the maximum junction temperature, $T_J(MAX)$, the junction-to-ambient thermal resistance, θ_{J-A} , and the ambient temperature, T_A . The maximum allowable power dissipation at any ambient temperature is calculated using:

$$P(MAX) = \frac{T_{J}(MAX) - T_{A}}{\theta_{J-A}}$$

Where the value of $\theta_{J,A}$ for the SOT-23 package is 220°C/W in a typical PC board mounting. Exceeding the maximum allowable dissipation will cause excessive die temperature, and the regulator will go into thermal shutdown.

Note 4: If used in a dual-supply system where the regulator load is returned to a negative supply, the LP2985LV output must be diode-clamped to ground. **Note 5:** The output PNP structure contains a diode between the V_{IN} to V_{OUT} terminals that is normally reverse-biased. Reversing the polarity from V_{IN} to V_{OUT} will turn on this diode, and possibly damage the device (See Application Hints).

Note 6: Limits are 100% production tested at 25°C. Limits over the operating temperature range are guaranteed through correlation using Statistical Quality Control (SQC) methods. The limits are used to calculate National's Average Outgoing Quality Level (AOQL).

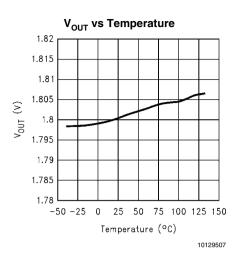
Note 7: The ON/OFF input must be properly driven to prevent possible misoperation. For details, refer to Application Hints.

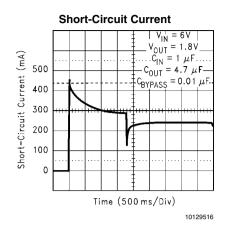
Note 8: The LP2985LV has foldback current limiting which allows a high peak current when $V_{OUT} > 0.5V$, and then reduces the maximum output current as V_{OUT} is forced to ground (see Typical Performance Characteristics curves).

Note 9: V_{IN} must be the greater of 2.2V or V_{OUT(NOM)} + Dropout Voltage to maintain output regulation. Dropout Voltage is defined as the input to output differential at which the output voltage drops 2% below ther value measured with a 1V differential.

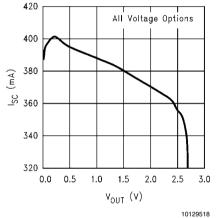
Note 10: Exposing the micro SMD device to direct sunlight will cause misoperation. See Application Hints for additional information.

Typical Performance Characteristics Unless otherwise specified: $C_{IN} = 1\mu$ F, $C_{OUT} = 4.7\mu$ F, $V_{IN} = V_{OUT}(NOM) + 1$, $V_{OUT} = 1.8$ V, $T_A = 25^{\circ}$ C, ON/OFF pin is tied to V_{IN}

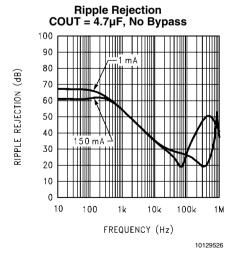




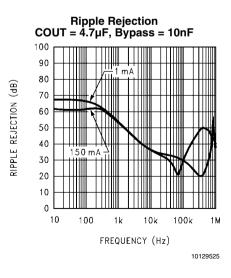
Short-Circuit Current vs Output Voltage



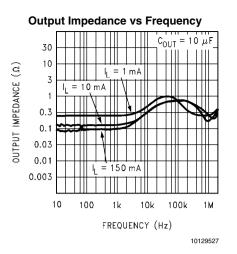


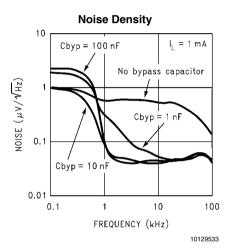


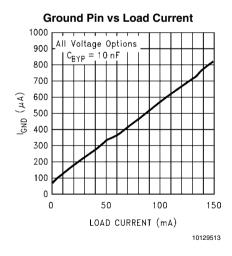
Short-Circuit Current 700 $V_{IN} = 16V$ V_{OUT} = 1.8V 600 Short-Circuit Current (mA) $C_{IN}^{UU} = 1 \ \mu F.$ 500 $C_{OUT} = 4.7 \ \mu F_{-}$ $C_{\text{BYPASS}} = 0.01 \ \mu\text{F}$ 400 300 200 100 0 Time (100 ms/Div) 10129517



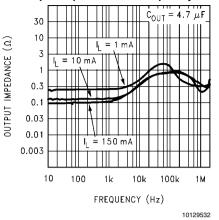
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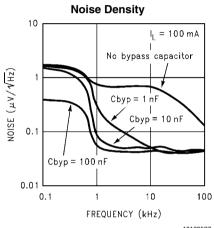






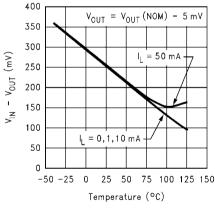
Output Impedance vs Frequency



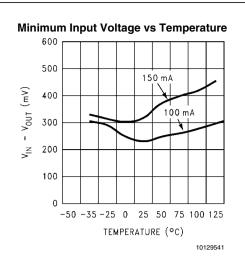


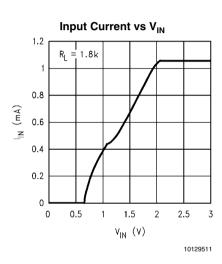


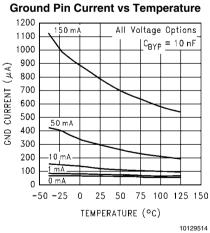


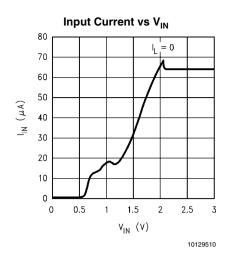


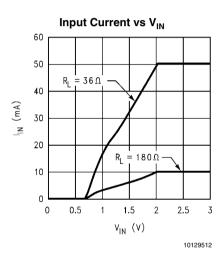
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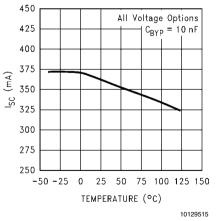


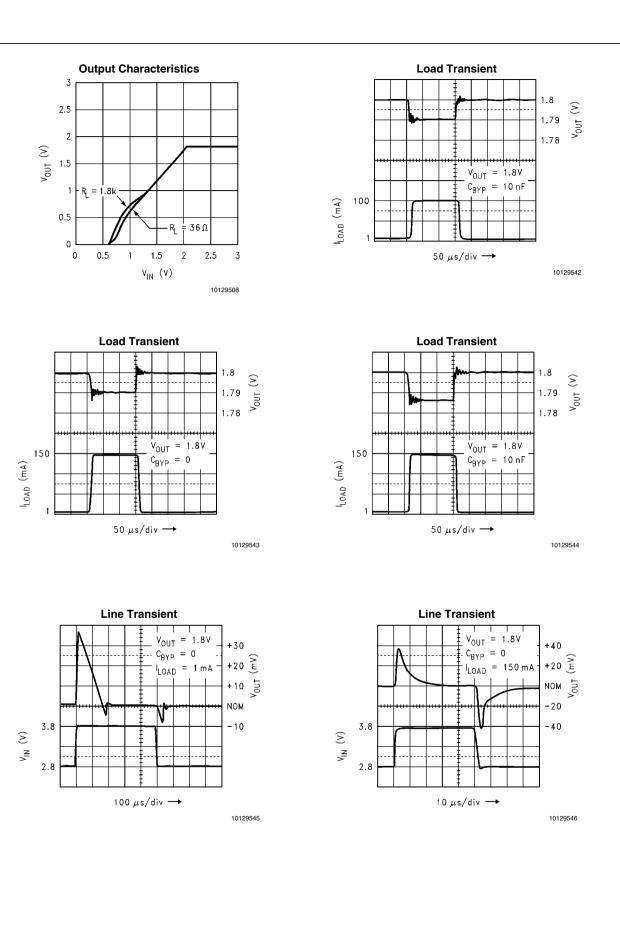






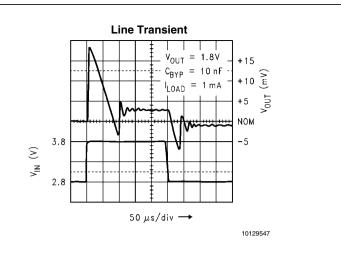
Instantaneous Short Circuit Current

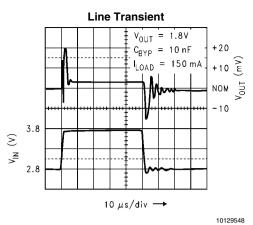




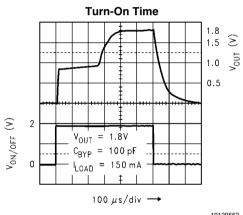
LP2985LV

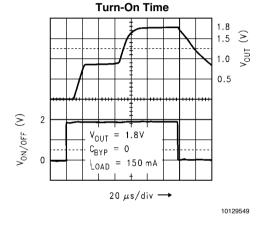


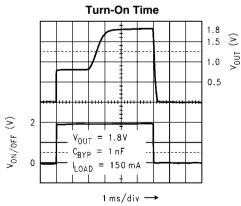


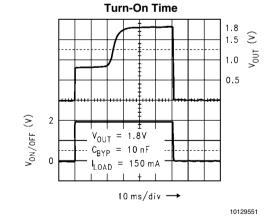












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Application Hints EXTERNAL CAPACITORS

Like any low-dropout regulator, the LP2985LV requires external capacitors for regulator stability. These capacitors must be correctly selected for good performance.

Input Capacitor

An input capacitor whose capacitance is $\geq 1 \ \mu F$ is required between the LP2985LV input and ground (the amount of capacitance may be increased without limit).

This capacitor must be located a distance of not more than 1 cm from the input pin and returned to a clean analog ground. Any good quality ceramic, tantalum, or film capacitor may be used at the input.

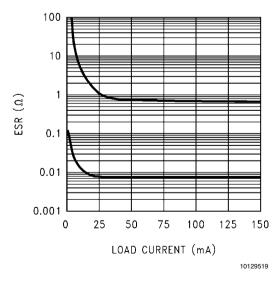
Important: Tantalum capacitors can suffer catastrophic failure due to surge current when connected to a low-impedance source of power (like a battery or very large capacitor). If a Tantalum capacitor is used at the input, it must be guaranteed by the manufacturer to have a surge current rating sufficient for the application.

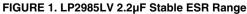
There are no requirements for ESR on the input capacitor, but tolerance and temperature coefficient must be considered when selecting the capacitor to ensure the capacitance will be $\geq 1 \ \mu$ F over the entire operating temperature range.

Output Capacitor

The LP2985LV is designed specifically to work with ceramic output capacitors, utilizing circuitry which allows the regulator to be stable across the entire range of output current with an output capacitor whose ESR is as low as 5 m Ω . It may also be possible to use Tantalum or film capacitors at the output, but these are not as attractive for reasons of size and cost (see next section *Capacitor Characteristics*).

The output capacitor must meet the requirement for minimum amount of capacitance and also have an ESR (equivalent series resistance) value which is within the stable range. Curves are provided which show the stable ESR range as a function of load current (see ESR graphs *Figure 1* and *Figure 2*).





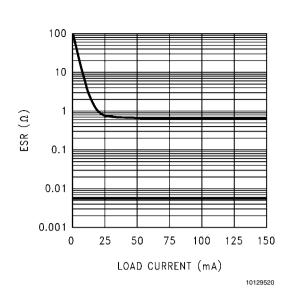


FIGURE 2. LP2985LV 4.7µF Stable ESR Range

Important: The output capacitor must maintain its ESR within the stable region over the full operating temperature range of the application to assure stability.

The LP2985LV requires a minimum of 2.2 μ F on the output (output capacitor size can be increased without limit).

It is important to remember that capacitor tolerance and variation with temperature must be taken into consideration when selecting an output capacitor so that the minimum required amount of output capacitance is provided over the full operating temperature range. It should be noted that ceramic capacitors can exhibit large changes in capacitance with temperature (see next section, *Capacitor Characteristics*).

The output capacitor must be located not more than 1 cm from the output pin and returned to a clean analog ground.

Noise Bypass Capacitor

Connecting a 10 nF capacitor to the Bypass pin significantly reduces noise on the regulator output. It should be noted that the capacitor is connected directly to a high-impedance circuit in the bandgap reference.

Because this circuit has only a few microamperes flowing in it, any significant loading on this node will cause a change in the regulated output voltage. For this reason, DC leakage current through the noise bypass capacitor must never exceed 100 nA, and should be kept as low as possible for best output voltage accuracy.

The types of capacitors best suited for the noise bypass capacitor are ceramic and film. High-quality ceramic capacitors with either NPO or COG dielectric typically have very low leakage. 10 nF polypropolene and polycarbonate film capacitors are available in small surface-mount packages and typically have extremely low leakage current.

CAPACITOR CHARACTERISTICS

The LP2985LV was designed to work with ceramic capacitors on the output to take advantage of the benefits they offer: for capacitance values in the 2.2 μ F to 4.7 μ F range, ceramics are the least expensive and also have the lowest ESR values (which makes them best for eliminating high-frequency noise). The ESR of a typical 2.2 μ F ceramic capacitor is in the range of 10 m Ω to 20 m Ω , which easily meets the ESR limits required for stability by the LP2985LV.

One disadvantage of ceramic capacitors is that their capacitance can vary with temperature. Most large value ceramic capacitors ($\geq 2.2 \ \mu$ F) are manufactured with the Z5U or Y5V temperature characteristic, which results in the capacitance dropping by more than 50% as the temperature goes from 25° C to 85°C.

This could cause problems if a 2.2 μ F capacitor were used on the output since it will drop down to approximately 1 μ F at high ambient temperatures (which could cause the LP2985LV to oscillate). If Z5U or Y5V capacitors are used on the output, a minimum capacitance value of 4.7 μ F must be observed.

A better choice for temperature coefficient in ceramic capacitors is X7R, which holds the capacitance within $\pm 15\%$. Unfortunately, the larger values of capacitance are not offered by all manufacturers in the X7R dielectric.

Tantalum

Tantalum capacitors are less desirable than ceramics for use as output capacitors because they are more expensive when comparing equivalent capacitance and voltage ratings in the 1 μ F to 4.7 μ F range.

Another important consideration is that Tantalum capacitors have higher ESR values than equivalent size ceramics. This means that while it may be possible to find a Tantalum capacitor with an ESR value within the stable range, it would have to be larger in capacitance (which means bigger and more costly) than a ceramic capacitor with the same ESR value.

It should also be noted that the ESR of a typical Tantalum will increase about 2:1 as the temperature goes from $25^{\circ}C$ down to $-40^{\circ}C$, so some guard band must be allowed.

On/Off Input Operation

The LP2985LV is shut off by driving the ON/OFF input low, and turned on by pulling it high. If this feature is not to be used, the ON/OFF input should be tied to $\rm V_{IN}$ to keep the regulator output on at all times.

To assure proper operation, the signal source used to drive the ON/OFF input must be able to swing above and below the specified turn-on/turn-off voltage thresholds listed in the Electrical Characteristics section under V_{ON/OFF}. To prevent misoperation, the turn-on (and turn-off) voltage signals applied to the ON/OFF input must have a slew rate which is \geq 40 mV/µs.

Caution: the regulator output voltage can not be guaranteed if a slow-moving AC (or DC) signal is applied that is in the range between the specified turn-on and turn-off voltages listed under the electrical specification $V_{ON/OFF}$ (see Electrical Characteristics).

REVERSE INPUT-OUTPUT VOLTAGE

The PNP power transistor used as the pass element in the LP2985LV has an inherent diode connected between the regulator output and input. During normal operation (where the input voltage is higher than the output) this diode is reversebiased.

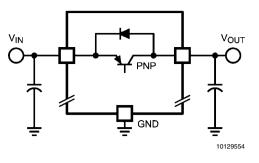


FIGURE 3. Reverse Current Parth

However, if the output is pulled above the input, this diode will turn ON and current will flow into the regulator output. In such cases, a parasitic SCR can latch which will allow a high current to flow into $V_{\rm IN}$ (and out the ground pin), which can damage the part.

In any application where the output may be pulled above the input, an external Schottky diode must be connected from $V_{\rm IN}$ to $V_{\rm OUT}$ (cathode on $V_{\rm IN}$, anode on $V_{\rm OUT}$), to limit the reverse voltage across the LP2985LV to 0.3V (see Absolute Maximum Ratings).

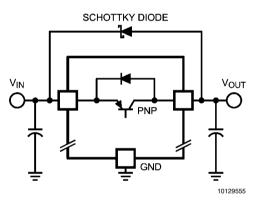


FIGURE 4. Reverse Current Protection

MICRO SMD MOUNTING

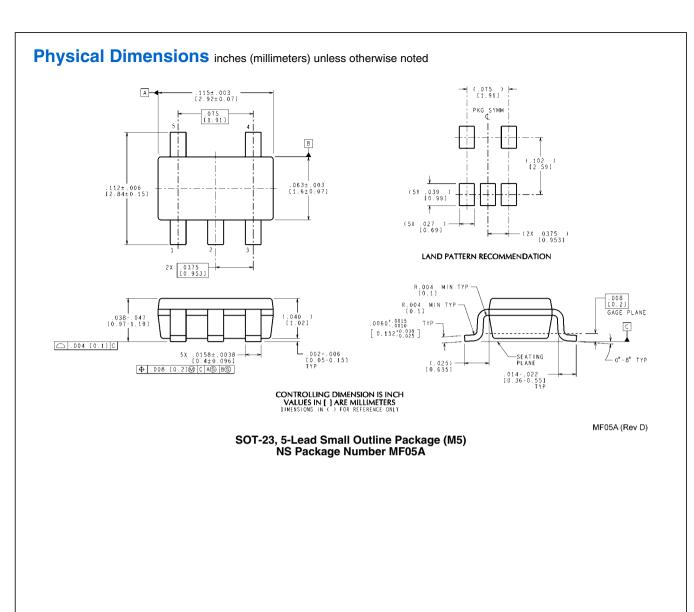
The micro SMD package requires specific mounting techniques which are detailed in National Semiconductor Application Note # 1112. Referring to the section *Surface Mount Technology (SMT) Assembly Considerations*, it should be noted that the pad style which must be used with the 5-pin package is the NSMD (non-solder mask defined) type.

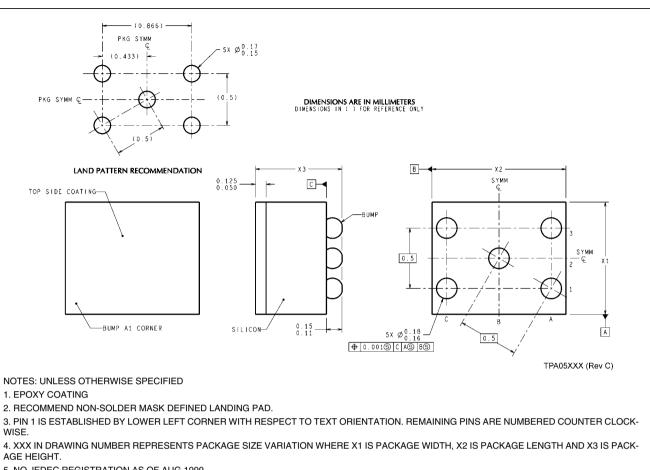
For best results during assembly, alignment ordinals on the PC board may be used to facilitate placement of the micro SMD device.

MICRO SMD LIGHT SENSITIVITY

Exposing the micro SMD device to direct sunlight will cause misoperation of the device. Light sources such as Halogen lamps can also affect electrical performance if brought near to the device.

The wavelengths which have the most detrimental effect are reds and infra-reds, which means that the fluorescent lighting used inside most buildings has very little effect on performance. A micro SMD test board was brought to within 1 cm of a fluorescent desk lamp and the effect on the regulated output voltage was negligible, showing a deviation of less than 0.1% from nominal.





5. NO JEDEC REGISTRATION AS OF AUG.1999.

micro SMD, 5 Bump, Package (TPA05 - 170 µm ball) NS Package Number TPA05 The dimensions for X1, X2 and X3 are as given: $\begin{array}{l} \text{X1} = 0.930 \text{ +/-} 0.030 \text{ mm} \\ \text{X2} = 1.107 \text{ +/-} 0.030 \text{ mm} \\ \text{X3} = 0.500 \text{ +/-} 0.075 \text{ mm} \end{array}$

Notes

LP2985LV

Notes

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